## Notice of References Cited Application/Control No. O9/510,966 Examiner BINH K. TIEU Applicant(s)/Patent Under Reexamination GAIKWARD ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	А	US-6,549,512 B2	04-2003	Wu et al.	370/210
	В	US-6,055,297 A	04-2000	Terry, John Brian	379/1.01
	С	US-6,101,172 A	08-2000	van Bavel et al.	370/295
	D	US-6,339,613 B2	01-2002	Terry, John Brian	375/227
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	I	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.